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8840A
DIGITAL MULTIMETER

Instruction Manual

P/N 684365
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Table 1-1. Specifications

DC VOLTAGE

Input Characteristics

	FULL SCALE	RESOLUTION		INPUT
RANGE	5½ DIGITS	5½ DIGITS	4½ DIGITS*	RESISTANCE
200 mV	199.999 mV	1 <i>μ</i> V	10 <i>μ</i> V	≽10,000 MΩ
2V	1.99999V	10 <i>μ</i> V	100 <i>μ</i> V	≥10,000 MΩ
20V	19.9999V	100 <i>μ</i> V	1 mV	≥10,000 MΩ
200V	199.999V	1 mV	10 mV	10 ΜΩ
1000V	1000.00V	10 mV	100 mV	10 ΜΩ

^{*41/2} digits at the fastest reading rate.

Accuracy

NORMAL (S) READING RATE \pm (% of Reading + Number of Counts).

RANGE	24 HOUR 23±1°C1	90 DAY 23±5°C	1 YEAR 23±5°C
200 mV ²	0.003 + 3	0.007 + 4	0.008 + 4
2V	0.002 + 2	0.004 + 3	0.005 + 3
20V	0.002 + 2	0.005 + 3	0.006 + 3
200V	0.002 + 2	0.005 + 3	0.006 + 3
1000V	0.003 + 2	0.005 + 3	0.007 + 3

¹ Relative to calibration standards.

MEDIUM AND FAST RATES: In medium rate, add 2 counts to number of counts. In fast rate, use 2 counts for the number of counts.

Operating Characteristics

MAXIMUM INPUT 1000V dc or peak ac on any range.

NOISE REJECTION Automatically optimized at power-up for 50, 60, or 400 Hz.

RATE	READINGS/ SECOND ¹	FILTER	NMRR ²	PEAK NM SIGNAL	CMRR ³
S	2.5	Analog & Digital	>98 dB	20V or 2x FS⁴	>140 dB
М	20	Digital	>45 dB	1x FS	>100 dB
F	100	None	_	1x FS	>60 dB

¹ Reading rate with internal trigger and 60 Hz power line frequency. See "Reading Rates" for more detail.

² Using Offset control.

 $^{^2}$ Normal Mode Rejection Ratio, at 50 or 60 Hz $\pm 0.1\%$. The NMRR for 400 Hz $\pm 0.1\%$ is 85 dB in S rate and 35 dB in M rate

 $^{^3}$ Common Mode Rejection Ratio at 50 or 60 Hz \pm 0.1%, with 1 k Ω in series with either lead. The CMRR is >140 dB at dc for all reading rates.

^{4 20} volts or 2 times Full Scale whichever is greater, not to exceed 1000V.

Table 1-1. Specifications (cont)

TRUE RMS AC VOLTAGE (OPTION -09) Input Characteristics

FULL SCALE		RESOLUTION		INPUT
RANGE	5½ DIGITS	5½ DIGITS	4½ DIGITS*	IMPEDANCE
200 mV	199.999 mV	1 <i>μ</i> V	10 <i>µ</i> V	1 ΜΩ
2V	1.99999V	10 <i>μ</i> V	100 μV	shunted
20V	19.9999V	100 μV	1 mV	by
200V	199.999V	1 mV	10 mV	<100 pF
700V	700.00V	10 mV	100 mV	,

^{*4}½ digits at the fastest reading rate.

Accuracy

NORMAL (S) READING RATE \pm (% of Reading + Number of Counts). For sinewave inputs ≥10,000 counts¹.

FREQUENCY (Hz)	24 HOURS ² 23±1°C	90 DAY 23±5°C	1 YEAR 23±5°C
20-45	1.2 + 100	1.2 + 100	1.2 + 100
45-100	0.3 + 100	0.35 + 100	0.4 + 100
100-20k	0.07 + 100	0.14 + 100	0.16 + 100
20k-50k	0.15 + 120	0.19 + 150	0.21 + 200
50k-100k	0.4 + 300	0.5 + 300	0.5 + 400

¹ For sine:vave inputs between 1,000 and 10,000 counts, add to Number of Counts 100 counts for frequencies 20 Hz to 20 kHz, 200 counts for 20 kHz to 50 kHz, and 500 counts for 50 kHz to 100 kHz.

MEDIUM AND FAST READING RATES ... In medium rate, add 50 counts to number of counts. In fast rate the specifications apply for sinewave inputs ≥1000 counts and >100 Hz.

NONSINUSOIDAL INPUTS For nonsinusoidal inputs ≥10,000 counts with frequency components ≤100 kHz, add the following % of reading to the accuracy specifications.

FUNDAMENTAL	CREST FACTOR		
FREQUENCY	1.0 TO 1.5	1.5 TO 2.0	2.0 TO 3.0
45 Hz to 20 kHz	0.05	0.15	0.3
20 Hz to 45 Hz and 20 kHz to 50 kHz	0.2	0.7	1.5

Operating Characteristics

less) for any range.

² Relative to calibration standards.

Table 1-1. Specifications (cont)

TEMPERATURE COEFFICIENT ±(% of Reading + Number of Counts) per °C, 0°C to 18°C and 28°C to 50°C.

	FREQUENCY IN HERTZ			
FOR INPUTS	20-20k	20k-50k	50k-100k	
≥10,000 counts	0.019 + 9	0.021 + 9	0.027 + 10	
≥1,000 counts	0.019 + 12	0.021 + 15	0.027 + 21	

COMMON MODE REJECTION >60 dB at 50 or 60 Hz with 1 k Ω in either lead.

CURRENT

Input Characteristics

	FULL SCALE	RESO	LUTION
RANGE	5½ DIGITS	5½ DIGITS	4½ DIGITS*
2000 mA	1999.99 mA	10 μΑ	100 μΑ

^{*41/2} digits at the fastest reading rate.

DC Accuracy

NORMAL (S) READING RATE \pm (% of Reading + Number of Counts).

	90 DAYS 23±5°C	1 YEAR 23±5°C
≤1A	0.04 + 4	0.05 + 4
>1A	0.1 + 4	0.1 + 4

MEDIUM AND FAST READING RATES ... In medium reading rate, add 2 counts to number of counts. In fast reading rate, use 2 counts for number of counts.

AC Accuracy (Option -09)

NORMAL (S) READING RATE \pm (% of Reading + Number of Counts). 1 Year, 23 \pm 5°C, for sinewave inputs \geqslant 10,000 counts.

FREQUENCY IN HERTZ					
20-45 45-100 100-5k*					
2.0 + 200	0.5 + 200	0.4 + 200			

^{*}Typically 20 kHz

Table 1-1. Specifications (cont)

MEDIUM AND FAST READING RATES ... In medium rate, add 50 counts to number of counts. In fast

reading rate, for sinewave inputs \geqslant 1000 counts and frequencies

>100 Hz, the accuracy is $\pm (0.2\%$ of reading + 30 counts).

NONSINUSOIDAL INPUTS For nonsinusoidal inputs ≥10,000 counts with frequency

components ${\leqslant}100$ kHz, add the following % of reading to the

accuracy specifications.

FUNDAMENTAL	CREST FACTOR			
FREQUENCY	1.0 TO 1.5	1.5 TO 2.0	2.0 TO 3.0	
45 Hz to 5 kHz	0.05	0.15	0.3	
20 Hz to 45 Hz	0.2	0.7	1.5	

Operating Characteristics

TEMPERATURE COEFFICIENT Less than 0.1 x accuracy specification per °C from 0°C to 18°C

and 28°C to 50°C.

panel, and internal 3A, 600V fuse.

BURDEN VOLTAGE 1V dc or rms ac typical at full scale.

RESISTANCE

Input Characteristics

RANGE FULL SCALE	RESOLUTION		CURRENT	
11/11402	5½ DIGITS	5½ DIGITS	4½ DIGITS*	THROUGH UNKNOWN
200Ω	199.999Ω	1 mΩ	10 mΩ	1 mA
2 kΩ	1.99999 kΩ	10 mΩ	100 mΩ	1 mA
20 kΩ	19.9999 kΩ	100 mΩ	1Ω	,100 μA
200 kΩ	199.999 kΩ	1Ω	10Ω	10 μA
2000 kΩ	1999.99 kΩ	10Ω	100Ω	5 μA
20 ΜΩ	19.9999 MΩ	100Ω	1 kΩ	0.5 μΑ

^{*41/2} digits at the fastest reading rate.

Accuracy

NORMAL (S) READING RATE ±(% of Reading + Number of Counts)¹

RANGE	24 HOUR 23±1°C2	90 DAY 23±5°C	1 YEAR 23±5°C
200Ω	0.004 + 3	0.011 + 4	0.014 + 4
2 kΩ	0.0028 + 2	0.01 + 3	0.013 + 3
20 kΩ	0.0028 + 2	0.01 + 3	0.013 + 3
200 kΩ	0.0028 + 2	0.01 + 3	0.013 + 3
2000 kΩ	0.023 + 3	0.027 + 3	0.028 + 3
20 ΜΩ	0.023 + 3	0.043 + 4	0.044 + 4

¹ Using Offset control.

² Relative to calibration standards.

Table 1-1. Specifications (cont)

Accuracy, cont

MEDIUM AND FAST READING RATES ... In medium rate, add 2 counts to the number of counts for the 200Ω through 200 k Ω ranges and 3 counts for the 2000 k Ω and 20 $M\Omega$ ranges. In fast reading rate, use 3 counts for the number of counts for the 200Ω range, and 2 counts for all other ranges.

Operating Characteristics

TEMPERATURE COEFFICIENT Less than 0.1 x accuracy specification per °C from 0°C to 18°C

and 28°C to 50°C.

MEASUREMENT CONFIGURATION 2-wire or 4-wire.

OPEN CIRCUIT VOLTAGE Less than 6.5V on the 200Ω through 200 kΩ ranges. Less than 13V

on the 2000 k Ω and 20 M Ω ranges.

INPUT PROTECTION To 300V rms.

READING RATES

READING RATES

WITH INTERNAL TRIGGER (readings per second).

RATE		POWER LINE FREQUENCY*	
	50 HZ	60 HZ	400 HZ
s	2.08	2.5	2.38
M	16.7	20	19.0
F	100	100	100

^{*}Sensed automatically at power-up.

AUTOMATIC SETTLING TIME DELAY

Time in milliseconds from single trigger to start of A/D conversion, Autorange off.

FUNCTION	RANGE	READING RATE		TE	NUMBER OF COUNTS
FUNCTION		S	М	F	FROM FINAL VALUE
VDC	200 mV	342	61	9	5
	2V-1000V	342	17	9	5
V.A.C	All	551	551	551	30 (Note 2)
mA DC	2000 mA	342	17	9	5
mA AC	2000 mA	551	551	551	30 (Note 2)
Ohms	200Ω	394	105	17	5
	2 kΩ	322	17	13	5
	20 kΩ	342	17	13	5
	200 kΩ	141	121	21	5
	2000 kΩ	141	101	81	10
	20 ΜΩ	1020	964	723	30

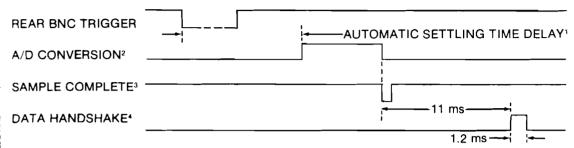
^{1.} Difference between first reading and final value for an in-range step change coincident with trigger.

^{2.} For slow reading rate, 50 counts for medium rate; 10 counts for fast rate.

Table 1-1. Specifications (cont)

EXTERNAL TRIGGER TIMING CHARACTERISTICS

The following diagram shows the nominal timing for the various processes which take place between an external trigger and data sent out on the IEEE-488 interface. Delays will vary if a second trigger comes before the data handshake is complete.



NOTES:

- 1. Time from single trigger to start of A/D conversion. (See "Automatic Settling Time Delay" on previous page.) If the delay is disabled by using the T3 or T4 command, then the delay is 1 ms ±150 μs. When the 8840A is triggered with an IEEE-488 command (GET or?), the automatic settling time delay begins after the trigger command has been processed and recognized.
- 2. A/D conversion time is dependent on the reading rate and power-line frequency:

RATE	A/D CONVERSION TIME (ms)		
	50 Hz	60 Hz	400 Hz
S	472	395	414
M F	52 7	45 7	47 7

- 3. Sample Complete is a $2.5 \mu s$ pulse which indicates that the analog input may be changed for the next reading.
- 4. When talking to a fast controller.

GENERAL

COMMON MODE VOLTAGE 1	1000V dc or peak ac, or 700V rms ac from any input to earth.
TEMPERATURE RANGE	0 to 50°C operating, -40 to 70°C storage.
HUMIDITY RANGE 8	80% RH from 0 to 35°C, 70% to 50°C.
WARMUP TIME 1	1 hour to rated specifications.
POWER 1	100, 120, 220, or 240V ac \pm 10% (250V ac maximum), switch
s	selectable at rear panel. 50, 60, or 400 Hz, automatically sensed at
	power-up. 20 VA maximum.
VIBRATION	Meets requirements of MIL-T-28800C for Type III, Class 3, Style E
	equipment.
PROTECTION	ANSI C39.5 and IEC 348, Class I.
SIZE 8	8.9 cm high, 21.6 cm wide, 37.1 cm deep(3.47 in high, 8.5 in wide,
	14.4 in deep).
WEIGHT	Net, 3.4 kg (7.5 lb); shipping, 5.0 kg (11 lb).
INCLUDED L	Line cord, test leads, Instruction/Service Manual, IEEE-488
	Quick Reference Guide, (Option -05 only), and instrument
F	performance record.
IEEE-488 INTERFACE FUNCTION (Option allows complete control and data output capability, and
s	supports the following interface function subsets: SH1, AH1, T5,
L	L4, SR1, RL1, DC1, DT1, E1, PP0, and C0.

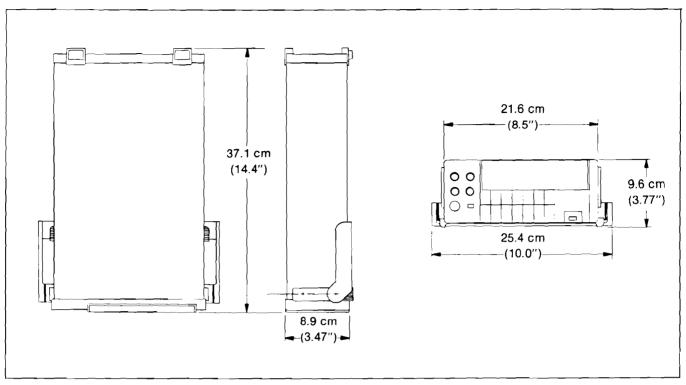


Figure 1-1. External Dimensions